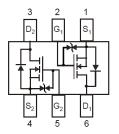


## **Main Product Characteristics:**

V <sub>DSS</sub>	60V	
R <sub>DS</sub> (on)	7.5ohm(max.)	
I <sub>D</sub>	A	





SOT-363

Schematic diagram

## **Features and Benefits:**

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



## **Description:**

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

# **Absolute max Rating:**

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	60	V
Gate-Source Voltage	VGS ±20		V
Dunin Courset Continuous @ Courset Dulgod (Note 4)	I <sub>D</sub>	0.115	А
Drain Current-Continuous@ Current-Pulsed (Note 1)	I <sub>DM</sub>	0.8	А
Maximum Power Dissipation	P <sub>D</sub>	0.38	W
Operating Junction and Storage Temperature Range	$T_{J}$ , $T_{STG}$	-55 To 150	$^{\circ}$

## **Thermal Resistance**

Thermal Resistance, Junction-to-Ambient (Note 2) R <sub>0JA</sub> 328	CW	
---	----	--



# **Electrical Characterizes** $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	60			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V,V <sub>GS</sub> =0V			1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V			±1	uA
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1		2	V
Danie Course On Otata Danietana	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A			7.5	0
Drain-Source On-State Resistance		V <sub>GS</sub> =5V, I <sub>D</sub> =0.05A			7.5	Ω
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =10V,I <sub>D</sub> =0.2A	0.08			S
Input Capacitance	C <sub>lss</sub>	\\ 45\\\\ 0\\		30		PF
Output Capacitance	Coss	$V_{DS}$ =15V, $V_{GS}$ =0V, F=1.0MHz		6		PF
Reverse Transfer Capacitance	C <sub>rss</sub>	1 – 1.01/11/12		3		PF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =30V, ID=0.2A,			20	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10V, $R_{GEN}$ =10 $\Omega$			40	nS

# **Source-Drain Ratings and Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Continuous Source Current				0.115	۸	MOSFET symbol
Is	(Body Diode)	_		0.115	Α	showing the
	Pulsed Source Current		_	0.8	А	integral reverse G ← + +
I <sub>SM</sub>	(Body Diode)	_				p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_	_	1.3	V	I <sub>S</sub> =0.2A, V <sub>GS</sub> =0V

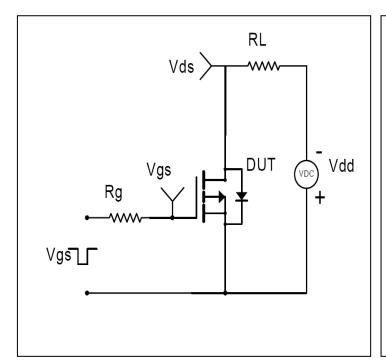
## NOTES:

- **1.** Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production testing.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



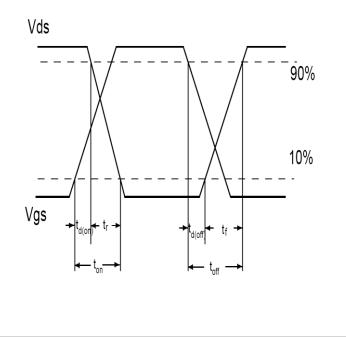


Figure 1: Switching Test Circuit

Figure 2: Switching Waveforms

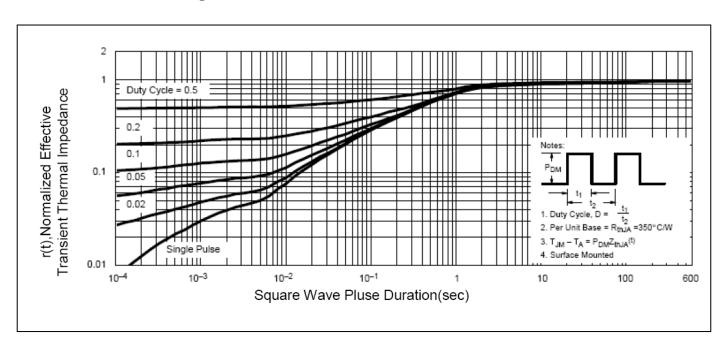
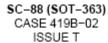
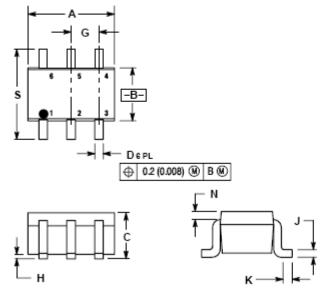


Figure 3. Maximum Effective Transient Thermal Impedance, Junction-to-Case



## **Mechanical Data:**





#### NOTES:

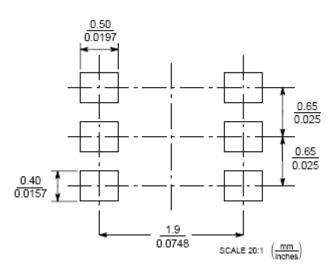
- DIMENSIONING AND TOLERANCING PER ANSI
  Y14.5M, 1982.
   CONTROLLING DIMENSION: INCH.
- 419B-01 OBSOLETE, NEW STANDARD 419B-02.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
A	0.071	0.087	1.80	2.20
В	0.045	0.053	1.15	1.35
С	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026	BSC	0.65	BSC
Н	i	0.004		0.10
J	0.004	0.010	0.10	0.25
K	0.004	0.012	0.10	0.30
N	0.008	REF	0.20	REF
	0.070	0.007	2.00	2.20

- STYLE 1: PIN 1. EMITTER 2 2. BASE 2 3. COLLECTOR 1 4. EMITTER 1 5. BASE 1

  - 6. COLLECTOR 2

### SOLDERING FOOTPRINT\*



## NOTES:

- 1. Dimensions are inclusive of plating
- 2. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
- 3. Dimension L is measured in gauge plane.
- 4. Controlling dimension is millimeter; converted inch dimensions are not necessarily exact.



# **Ordering and Marking Information**

Device Marking: 702

Package (Available)
SOT-363
Operating Temperature Range
C: -55 to 150 °C

# **Devices per Unit**

Package Type	Units/ Tape	Tapes/Inner Box	Units/Inner Box	Inner Boxes/Carton	Units/Carton Box
				Box	
SOT-363	3000	10	30000	4	120000

**Reliability Test Program** 

Test Item	Conditions	Duration	Sample Size
High	T <sub>j</sub> =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V <sub>DSS</sub> /V <sub>CES</sub> /VR	1000 hours	
Bias(HTRB)			
High	T <sub>j</sub> =150℃ or 150℃ @	168 hours	3 lots x 77 devices
Temperature	100% of Max V <sub>GSS</sub>	500 hours	
Gate		1000 hours	
Bias(HTGB)			

Version: 1.1



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